

Notice of References Cited	Application/Control No. 10/774,594	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner MARK A. X RADTKE	Art Unit 2165	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,643,652 B2	11-2003	Helgeson et al.	707/10
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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